

RF Power Field Effect Transistor

N-Channel Enhancement-Mode Lateral MOSFET

Designed for GSM and GSM EDGE base station applications with frequencies from 1800 to 2000 MHz. Suitable for TDMA, CDMA and multicarrier amplifier applications. To be used in Class AB for PCN-PCS/cellular radio and WLL applications. Specified for GSM-GSM EDGE 1805-1880 MHz.

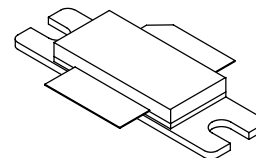
- GSM and GSM EDGE Performance, Full Frequency Band (1805-1880 MHz)
Power Gain - 15 dB (Typ) @ 85 Watts CW
Efficiency - 52% (Typ) @ 85 Watts CW
- Capable of Handling 5:1 VSWR, @ 26 Vdc, 1840 MHz, 85 Watts CW Output Power

Features

- Internally Matched for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Available with Low Gold Plating Thickness on Leads. L Suffix Indicates 40μ" Nominal.
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

MRF18085ALR3

**1805-1880 MHz, 85 W, 26 V
GSM/GSM EDGE
LATERAL N-CHANNEL
RF POWER MOSFET**



**CASE 465-06, STYLE 1
NI-780**

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Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	-0.5, +65	Vdc
Gate-Source Voltage	V _{GS}	-0.5, +15	Vdc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	273 1.56	W W/°C
Storage Temperature Range	T _{stg}	- 65 to +150	°C
Case Operating Temperature	T _C	150	°C
Operating Junction Temperature	T _J	200	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (1)	Unit
Thermal Resistance, Junction to Case	R _{θJC}	0.79	°C/W

Table 3. ESD Protection Characteristics

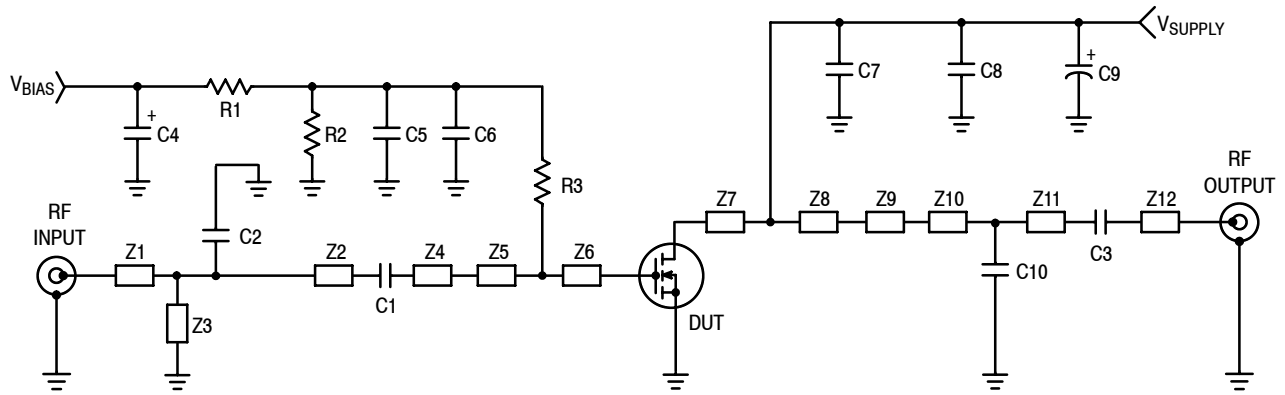
Test Conditions	Class
Human Body Model	1 (Minimum)
Machine Model	M3 (Minimum)

1. Refer to AN1955/D, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>.
Select Documentation/Application Notes - AN1955.

Table 4. Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted)

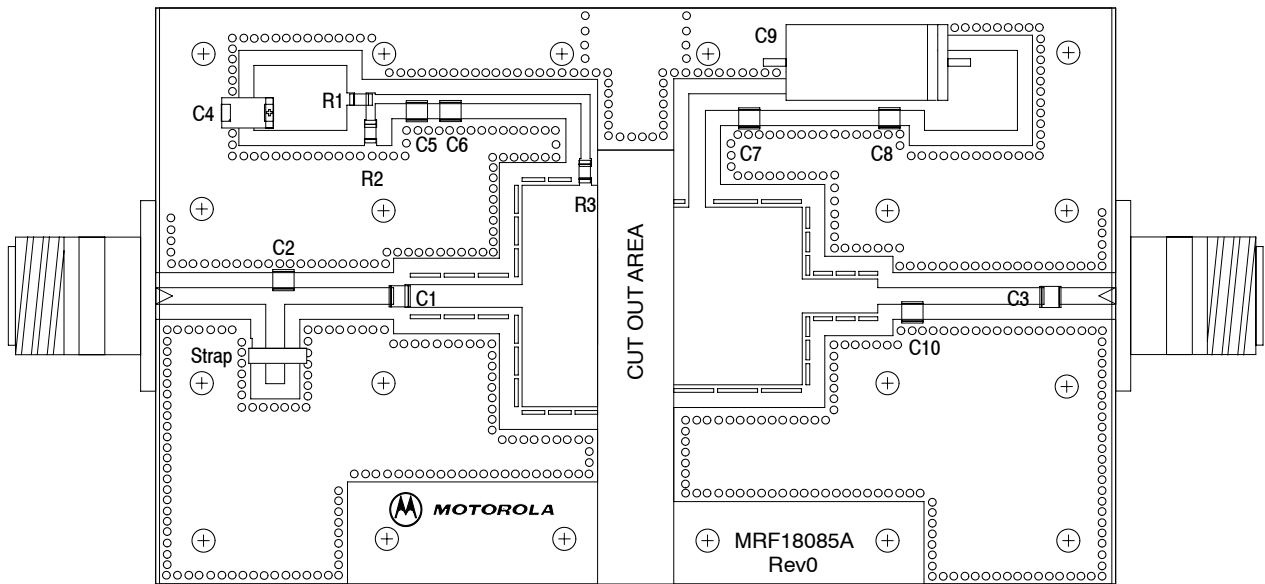
Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics					
Drain-Source Breakdown Voltage ($V_{GS} = 0\text{ Vdc}$, $I_D = 100\ \mu\text{Adc}$)	$V_{(BR)DSS}$	65	—	—	Vdc
Zero Gate Voltage Drain Current ($V_{DS} = 26\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	10	μAdc
Gate-Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	—	—	1	μAdc
On Characteristics					
Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 200\ \mu\text{Adc}$)	$V_{GS(th)}$	2	—	4	Vdc
Gate Quiescent Voltage ($V_{DS} = 26\text{ Vdc}$, $I_D = 600\ \text{mAdc}$)	$V_{GS(Q)}$	2.5	3.9	4.5	Vdc
Drain-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 2\text{ Adc}$)	$V_{DS(on)}$	—	0.15	—	Vdc
Dynamic Characteristics					
Reverse Transfer Capacitance (1) ($V_{DS} = 26\text{ Vdc}$, $V_{GS} = 0$, $f = 1\text{ MHz}$)	C_{rss}	—	3.6	—	pF
Functional Tests (In Freescale Test Fixture, 50 ohm system)					
Common-Source Amplifier Power Gain @ 85 W (2) ($V_{DD} = 26\text{ Vdc}$, $I_{DQ} = 800\text{ mA}$, $f = 1805 - 1880\text{ MHz}$)	G_{ps}	13.5	15	—	dB
Drain Efficiency @ 85 W (2) ($V_{DD} = 26\text{ Vdc}$, $I_{DQ} = 800\text{ mA}$, $f = 1805 - 1880\text{ MHz}$)	η	48	52	—	%
Input Return Loss @ 85 W (2) ($V_{DD} = 26\text{ Vdc}$, $I_{DQ} = 800\text{ mA}$, $f = 1805 - 1880\text{ MHz}$)	IRL	—	-12	-9	dB
Power Output, 1 dB Compression Point ($V_{DD} = 26\text{ Vdc}$, $I_{DQ} = 800\text{ mA}$, $f = 1805 - 1880\text{ MHz}$)	P1dB	83	90	—	Watts

1. Part is internally matched both on input and output.
2. To meet application requirements, Freescale test fixtures have been designed to cover the full GSM1800 band, ensuring batch-to-batch consistency.



C1, C3, C6, C7	10 pF Chip Capacitors, ATC	Z4	0.610" x 0.118" Microstrip
C2	1.8 pF Chip Capacitor, ATC	Z5	0.331" x 1.153" Microstrip
C4	10 μ F, 35 V Tantalum Capacitor, AVX	Z6	0.063" x 1.153" Microstrip
C5, C8	1 nF Chip Capacitors, ATC	Z7	0.122" x 0.925" Microstrip
C9	220 μ F, 63 V Electrolytic Capacitor, Radial, Philips	Z8	0.547" x 0.925" Microstrip
C10	0.3 pF Chip Capacitor, ATC	Z9	0.394" x 0.177" Microstrip
R1, R2	10 k Ω , 1/4 W Chip Resistors (1206)	Z10	0.180" x 0.087" Microstrip
R3	1.0 k Ω , 1/4 W Chip Resistor (1206)	Z11	0.686" x 0.087" Microstrip
Z1	0.671" x 0.087" Microstrip	Z12	0.294" x 0.087" Microstrip
Z2	0.568" x 0.087" Microstrip	PCB	Taconic TLX8, 30 mils, $\epsilon_r = 2.55$
Z3	0.500" x 0.098" Microstrip Shorted Stub		

Figure 1. 1805-1880 MHz Test Fixture Schematic



Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

Figure 2. 1805-1880 MHz Test Fixture Component Layout

TYPICAL CHARACTERISTICS

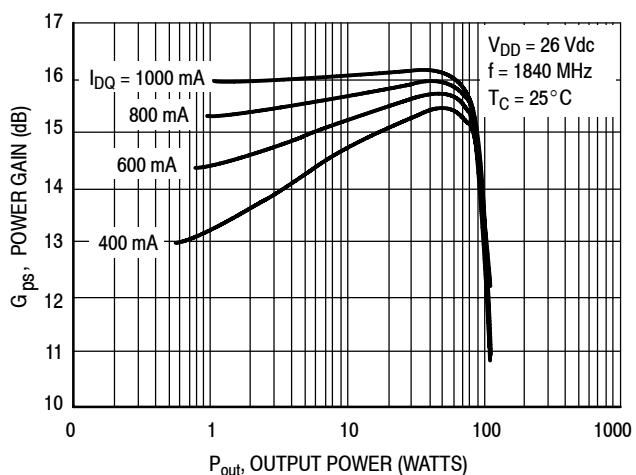


Figure 3. Power Gain versus Output Power

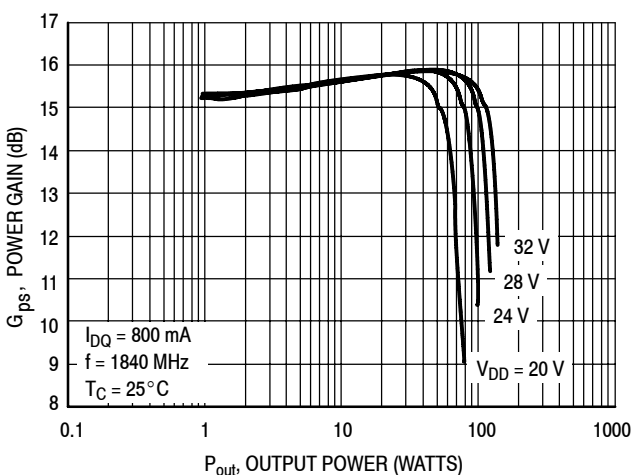


Figure 4. Power Gain versus Output Power

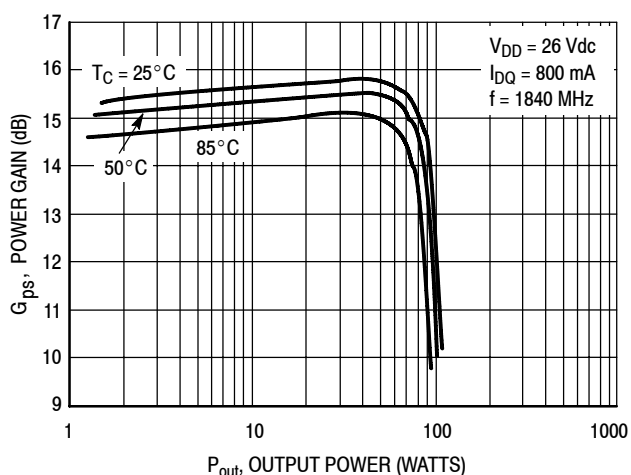


Figure 5. Power Gain versus Output Power

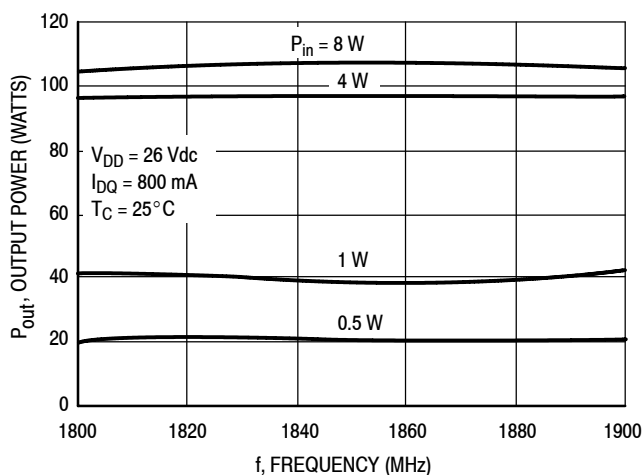


Figure 6. Output Power versus Frequency

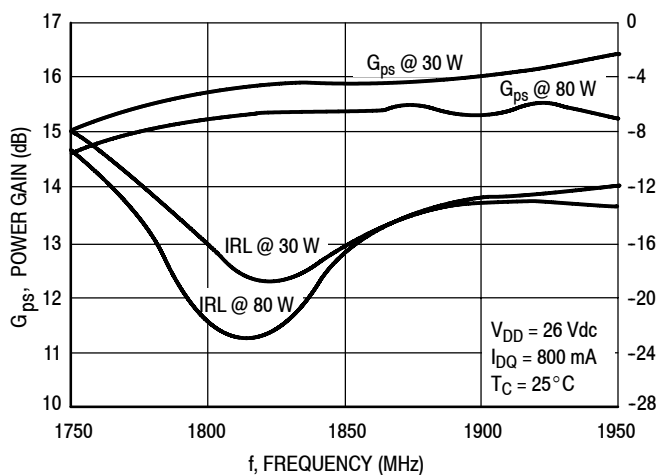


Figure 7. Power Gain versus Frequency

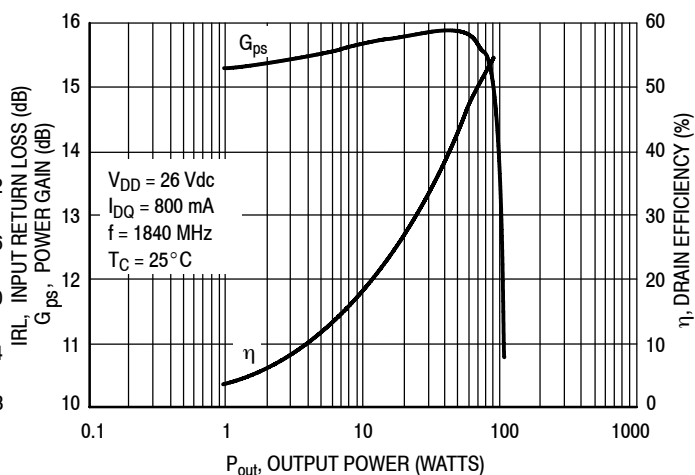
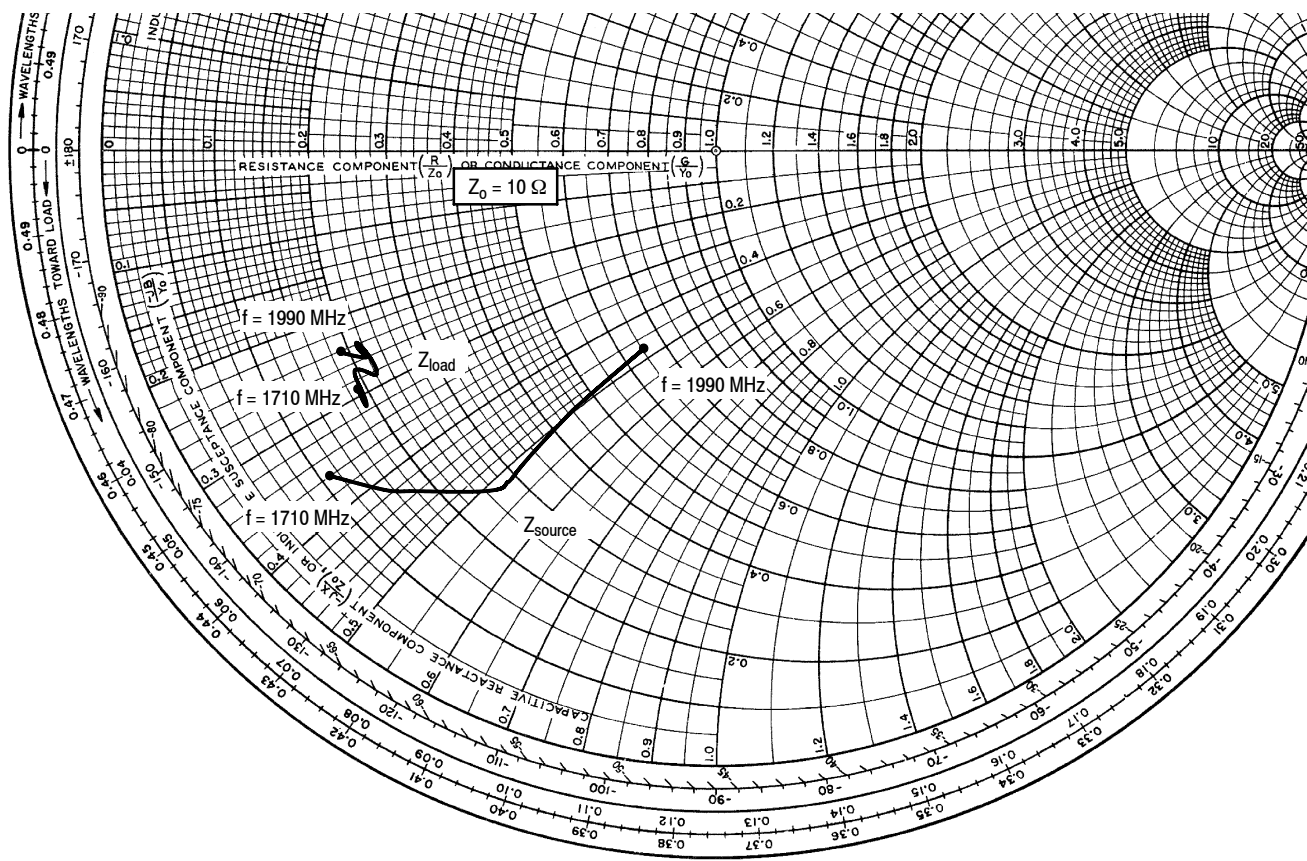


Figure 8. Power Gain and Efficiency versus Output Power

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$V_{DD} = 26\text{ V}$, $I_{DQ} = 800\text{ mA}$, $P_{out} = 85\text{ W CW}$

f MHz	Z_{source} Ω	Z_{load} Ω
1710	$1.13 - j3.62$	$1.79 - j2.88$
1785	$1.61 - j4.23$	$1.82 - j3.15$
1805	$1.69 - j4.34$	$1.90 - j2.66$
1880	$2.83 - j5.25$	$2.09 - j2.77$
1930	$3.00 - j5.18$	$2.01 - j2.44$
1960	$4.39 - j4.97$	$2.01 - j2.57$
1990	$6.59 - j4.74$	$1.79 - j2.37$

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

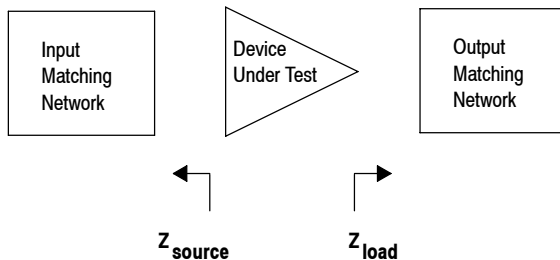
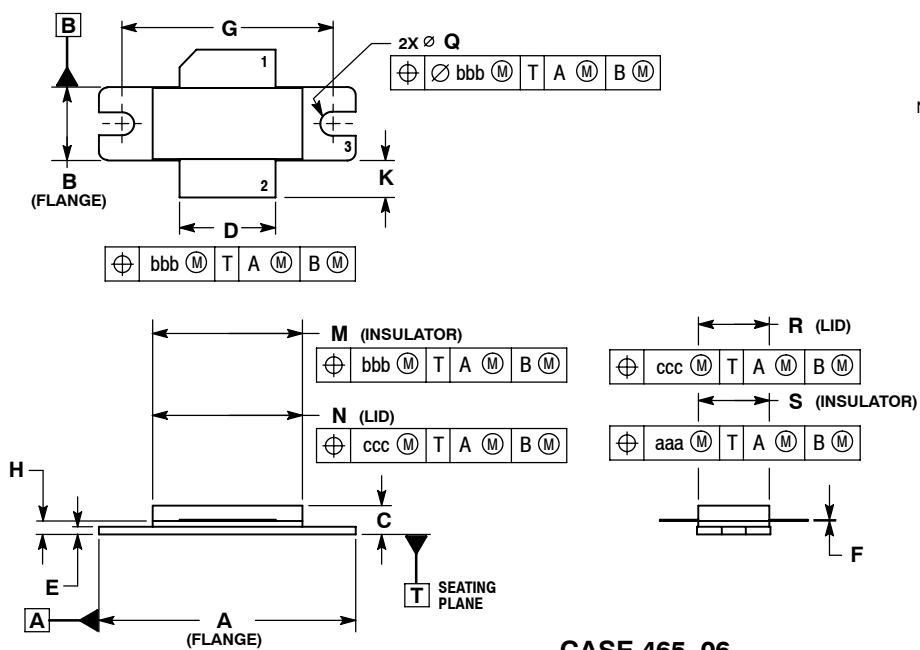


Figure 9. Series Equivalent Source and Load Impedance

PACKAGE DIMENSIONS



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
 2. CONTROLLING DIMENSION: INCH.
 3. DELETED
 4. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16
B	0.380	0.390	9.65	9.91
C	0.125	0.170	3.18	4.32
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
G	1.100 BSC		27.94 BSC	
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.774	0.786	19.66	19.96
N	0.772	0.788	19.60	20.00
Q	∅.118	∅.138	∅3.00	∅3.51
R	0.365	0.375	9.27	9.53
S	0.365	0.375	9.27	9.52
aaa	0.005 REF		0.127 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

- STYLE 1:
 PIN 1. DRAIN
 2. GATE
 3. SOURCE

**CASE 465-06
 ISSUE G
 NI-780
 MRF18085ALR3**

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REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
7	Oct. 2008	<ul style="list-style-type: none"> • Data sheet revised to reflect part status change, p. 1, including use of applicable overlay. • Added Revision History, p. 7 • Data sheet split due to change in part life cycle (-1, -2 added to enable visibility on web).
	Dec. 2010	<ul style="list-style-type: none"> • MRF18085A-1 Rev. 7 (MRF18085ALR3) data sheet archived. Part no longer manufactured. See MRF18085A-2 Rev. 8 for MRF18085ALSR3.

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